

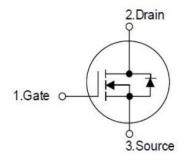


30N100

General Description

V _{(BR)DSS}	R _{DS(ON)_max}	I_D
30V	4.2mΩ@10V	1004
30 V	7mΩ@4.5V	100A

Symbol



Symbol of 30N100

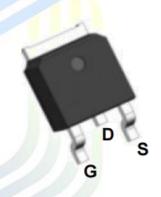
Features

- Excellent package for good heat dissipation
- Advanced Trench technology
- High density cell design for ultra low Rdson

Application

- Power switching application
- Uninterruptible power supply
- Hard switched and high frequency circuits

Package Type



TO-252

Package Type of 30N100

Ordering Information

Product Name	Package
30N100	TO-252



30N100

Absolute Maximum Ratings(T_A= 25 °C, unless otherwise specified)

Parameter	Symbol	Rating	Unit	
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current ^{Note 1}	T _C =25°C	I_D	100	A
Pulsed Drain Current ^{Note 2}	T _C =25°C	I_{DM}	400	A
Max Power Dissipation Note 3	T _C =25°C	P_{D}	58	W
Avalanche Energy, Single Pulse Note 4		Eas	210	mJ
Operation and Storage junction temperature		T_{J},T_{SGT}	-55 to 150	°C

Thermal Resistance

Parameter Parame	Symbol	Min Min	T <mark>y</mark> p	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	-	2.166	-	°C/W

Notes:

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) P_D is based on max. junction temperature, using junction-case thermal resistance.
- 4) V_{DD} = 30V, V_{GS} = 10 V, L=0.5 mH, starting T_{J} =25 °C.





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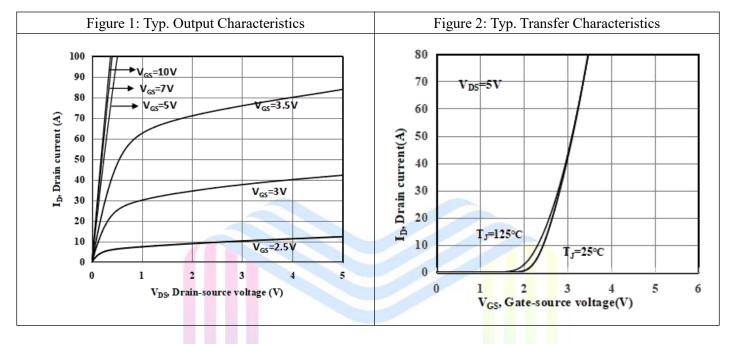
Electrical Characteristics(T_A= 25 °C, unless otherwise specified)

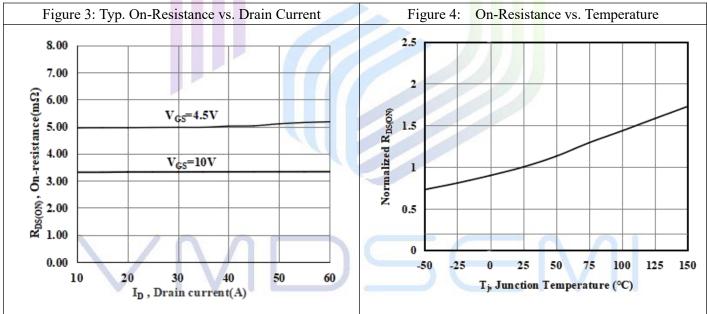
Parameter	Symbol	ymbol Test Conditions		Тур	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} =0V, I_{D} =250uA	30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} =30V, V_{GS} =0V	-	-	1	uA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_D=250uA$	1.0	1.5	2.5	V
Static Drain-Source On-Resistance	D	$V_{GS}=10V, I_{D}=30A$	-	3.3	4.2	mΩ
Static Drain-Source On-Resistance	R _{DS(ON)}	V_{GS} =4.5V, I_{D} =20A	-	5	7	
Gate Resistance	R_{G}	f=1MHz, Open Drain	-	1	1	Ω
Dynamic Characteristics	Dynamic Characteristics					
Input Capacitance	Ciss	$V_{GS}=0V$	-	2653	ı	pF
Output Capacitance	Coss	$V_{DS}=15V$	-	289	1	pF
Reverse Transfer Capacitance	C_{rss}	f=1MHz	-	219	-	pF
Turn-on Delay Time	t _{d(on)}	$V_{DD}=15V$	-	11.1	-	
Rise Time	$t_{\rm r}$	$V_{GS}=10V$	-	41	-	ng
Turn-off Delay Time	$t_{d(off)}$	$I_D=30A$	-	37.9	-	ns
Fall Time	t_{f}	$R_G=3\Omega$	-	11.2	1	
Gate Charge Characteristics						
Total Gate Charge	Q_{g}	V _{GS} =10V	1-1	50.2	1	
Gate to Source Charge	Q_{gs}	$V_{DS}=25V$	9' <u>-</u> /8	10.5	1	пC
Gate to Drain Charge	Q_{gd}	$I_D=30A$	19	10.8	-	
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V$, $I_S=30A$	-	0.86	1.2	V
Reverse Recovery Time	t _{rr}	VDD=20V I _F =20A	-	9.5	-	ns
Reverse Recovery Charge	Qrr	di/dt=100A/us	-	1.2	-	nC



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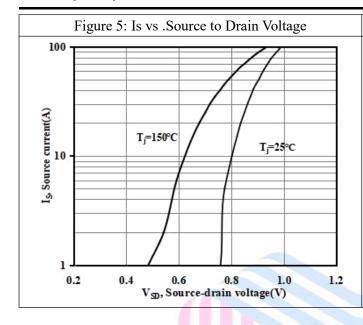
Typical Performance Characteristics

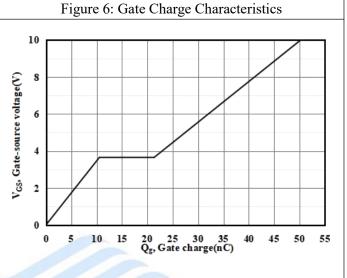


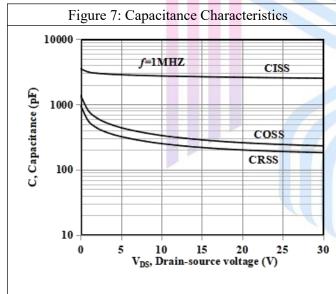


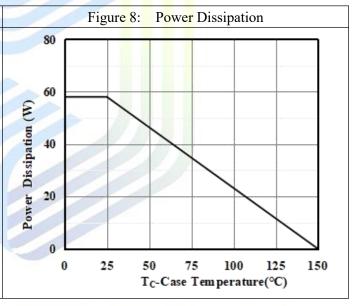


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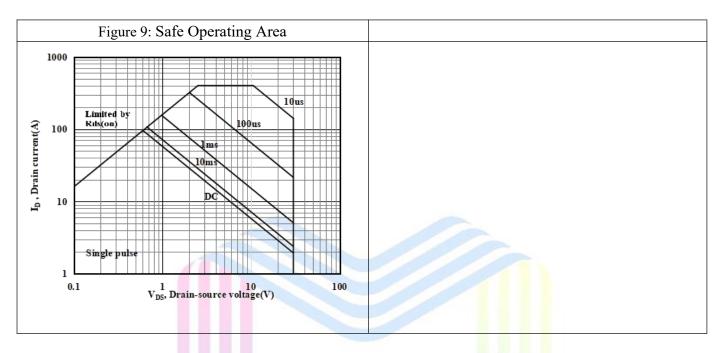


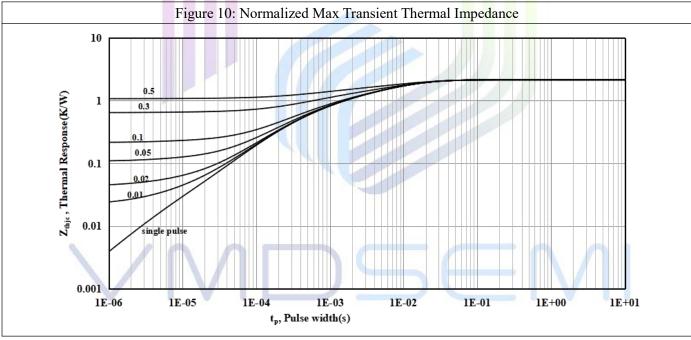








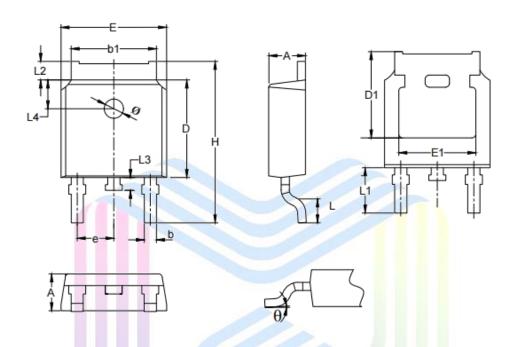






Mechanical Dimensions

TO-252 Package Information



SYMBOL	MILLIMETERS			
STMBOL	MIN	MAX		
A	2.2	2.4		
A1	0	0.127		
A2		_		
ь	0.66	0.9		
b1	5.1	5.5		
С	0.43	0.61		
D	5.95	6.22		
D1	5.3REF			
Е	6.4	6.75		
E1	4.8REF			
e	2.286BSC			
Н	9.4	10.5		
L	1.38	2		
L1	2.9REF			
L2	0.88	1.28		
L3	0.5	1		
L4	1.8REF			
θ	0° 8°			

30N100

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Via-Media Semiconductor Limited Company

http://www.vmdsemi.com

Main Sites:

- Headquarters

Hangzhou Via-Media Semiconductor Co., LTD. 1305-1306, Building 71, No. 90, Wensan Road, Xihu District, Hangzhou, Zhejiang Province, P.R. China Tel: +86-0571-8515 0563

- Shanghai

Shanghai R&D Center. 1506~1508, Xinyin Building, 888 Yishan Road, Shanghai, P.R of China

Tel: +86-021-54201999

- Xi'an

Xi'an R&D Center Room 10504, Building 2, Central Plaza, Jinye Road, High tech Zone, Xi'an City, Shanxi Province, R.P. of China

- Chengdu Office

Chengdu Winhi Semiconductor Co., LTD. Floor 15, Building 5, No. 171, Hele 2nd Street, Chengdu, Sichuan Province, P.R. China Tel: +86-028-8505 0771

- Shenzhen

Shenzhen Sales office.

Room 4A15, Block AB, Tianxiang Building, Chegongmiao, Futian District, Shenzhen, P.R of China

Tel: +86-0755-82570682